# SWITCHMODE™ Power Rectifier 30 V, 30 A

#### **Features and Benefits**

- Low Forward Voltage
- Low Power Loss/High Efficiency
- High Surge Capacity
- 150°C Operating Junction Temperature
- 30 A Total (15 A Per Diode Leg)
- Guard-Ring for Stress Protection
- This is a Pb-Free Device\*

#### **Applications**

- Power Supply Output Rectification
- Power Management
- Instrumentation

#### **Mechanical Characteristics:**

- Case: Epoxy, Molded
- Epoxy Meets UL 94 V-0 @ 0.125 in
- Weight: 1.5 Grams (Approximately)
- Finish: All External Surfaces Corrosion Resistant and Terminal Leads are Readily Solderable
- Lead Temperature for Soldering Purposes: 260°C Max. for 10 Seconds

#### **MAXIMUM RATINGS**

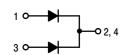
Please See the Table on the Following Page



#### ON Semiconductor®

http://onsemi.com

# SCHOTTKY BARRIER RECTIFIER 30 AMPERES, 30 VOLTS





I<sup>2</sup>PAK (TO-262) CASE 418D PLASTIC



**MARKING** 

B30H30 = Device Code A = Assembly Location

Y = Year
WW = Work Week
G = Pb-Free Package
AKA = Polarity Designator

#### **ORDERING INFORMATION**

Device	Package	Shipping
MBRB30H30CT-1G	TO-262 (Pb-Free)	50 Units/Rail

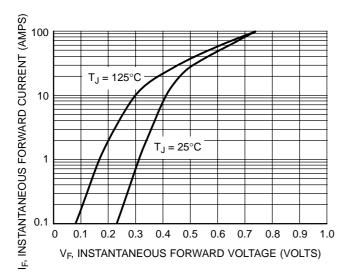
<sup>\*</sup>For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### MAXIMUM RATINGS (Per Diode Leg)

Rating		Value	Unit
Peak Repetitive Reverse Voltage Working Peak Reverse Voltage DC Blocking Voltage	V <sub>RRM</sub> V <sub>RWM</sub> V <sub>R</sub>	30	V
Average Rectified Forward Current (Rated V <sub>R</sub> ) T <sub>C</sub> = 138°C	I <sub>F(AV)</sub>	15	А
Peak Repetitive Forward Current (Rated V <sub>R</sub> , Square Wave, 20 kHz)	I <sub>FRM</sub>	30	Α
Nonrepetitive Peak Surge Current (Surge applied at rated load conditions halfwave, single phase, 60 Hz)	I <sub>FSM</sub>	260	А
Operating Junction Temperature (Note 1)	TJ	-55 to +150	°C
Storage Temperature	T <sub>stg</sub>	-55 to +150	°C
Voltage Rate of Change (Rated V <sub>R</sub> )	dv/dt	10,000	V/μs
Controlled Avalanche Energy (see test conditions in Figures 9 and 10)	W <sub>AVAL</sub>	250	mJ
ESD Ratings: Machine Model = C Human Body Model = 3B		> 400 > 8000	V
THERMAL CHARACTERISTICS			
Maximum Thermal Resistance – Junction-to-Case – Junction-to-Ambient	R <sub>θJC</sub> R <sub>θJA</sub>	2.0 70	°C/W
ELECTRICAL CHARACTERISTICS (Per Diode Leg)			
Maximum Instantaneous Forward Voltage (Note 2) $ \begin{aligned} (I_F &= 15 \text{ A, } T_C = 25^\circ\text{C}) \\ (I_F &= 15 \text{ A, } T_C = 125^\circ\text{C}) \\ (I_F &= 30 \text{ A, } T_C = 25^\circ\text{C}) \\ (I_F &= 30 \text{ A, } T_C = 125^\circ\text{C}) \end{aligned} $	VF	0.48 0.40 0.55 0.53	V
Maximum Instantaneous Reverse Current (Note 2) (Rated DC Voltage, T <sub>C</sub> = 25°C) (Rated DC Voltage, T <sub>C</sub> = 125°C)	i <sub>R</sub>	0.8 130	mA

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect

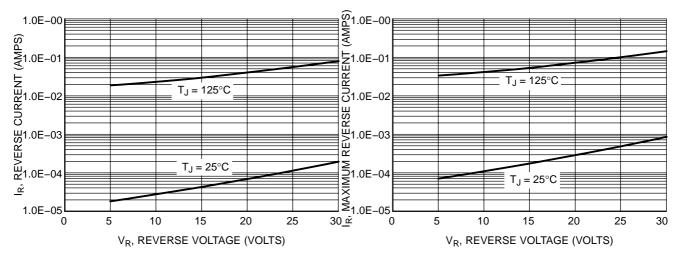
- 1. The heat generated must be less than the thermal conductivity from Junction–to–Ambient:  $dP_D/dT_J < 1/R_{\theta JA}$ . 2. Pulse Test: Pulse Width = 300  $\mu$ s, Duty Cycle  $\leq$  2.0%.



100 T<sub>J</sub> = 125°C T<sub>J</sub> = 25°C T

Figure 1. Typical Forward Voltage

Figure 2. Maximum Forward Voltage



**Figure 3. Typical Reverse Current** 

Figure 4. Maximum Reverse Current

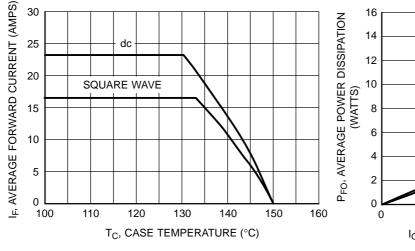


Figure 5. Current Derating

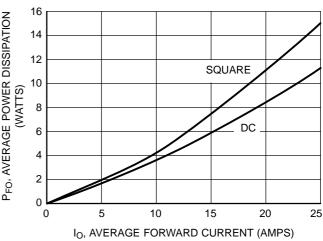


Figure 6. Forward Power Dissipation

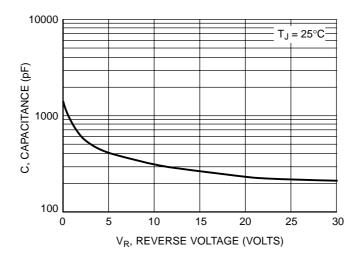


Figure 7. Capacitance

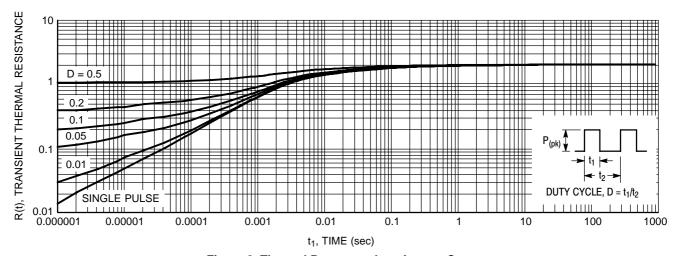


Figure 8. Thermal Response Junction-to-Case

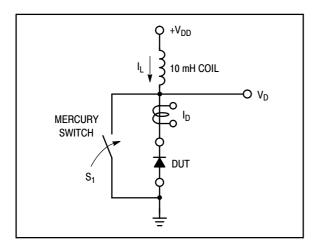


Figure 9. Test Circuit

The unclamped inductive switching circuit shown in Figure 9 was used to demonstrate the controlled avalanche capability of this device. A mercury switch was used instead of an electronic switch to simulate a noisy environment when the switch was being opened.

When  $S_1$  is closed at  $t_0$  the current in the inductor  $I_L$  ramps up linearly; and energy is stored in the coil. At  $t_1$  the switch is opened and the voltage across the diode under test begins to rise rapidly, due to di/dt effects, when this induced voltage reaches the breakdown voltage of the diode, it is clamped at  $BV_{DUT}$  and the diode begins to conduct the full load current which now starts to decay linearly through the diode, and goes to zero at  $t_2$ .

By solving the loop equation at the point in time when  $S_1$  is opened; and calculating the energy that is transferred to the diode it can be shown that the total energy transferred is equal to the energy stored in the inductor plus a finite amount of energy from the  $V_{DD}$  power supply while the diode is in breakdown (from  $t_1$  to  $t_2$ ) minus any losses due to finite component resistances. Assuming the component resistive

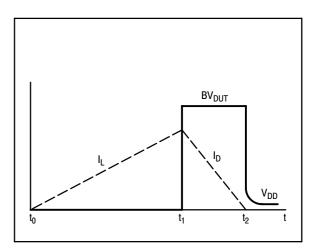


Figure 10. Current-Voltage Waveforms

elements are small Equation (1) approximates the total energy transferred to the diode. It can be seen from this equation that if the  $V_{DD}$  voltage is low compared to the breakdown voltage of the device, the amount of energy contributed by the supply during breakdown is small and the total energy can be assumed to be nearly equal to the energy stored in the coil during the time when  $S_1$  was closed, Equation (2).

### **EQUATION (1):**

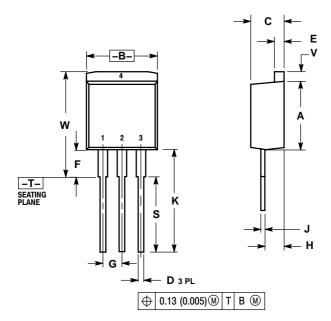
$$W_{AVAL} \approx \frac{1}{2} LI_{LPK}^2 \left( \frac{BV_{DUT}}{BV_{DUT}^{-V}_{DD}} \right)$$

#### **EQUATION (2):**

$$W_{AVAL} \approx \frac{1}{2}LI_{LPK}^2$$

#### **PACKAGE DIMENSIONS**

I<sup>2</sup>PAK (TO-262) CASE 418D-01 ISSUE C



- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ANSI V1// 5M 1082
  - 2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.335	0.380	8.51	9.65
В	0.380	0.406	9.65	10.31
С	0.160	0.185	4.06	4.70
D	0.026	0.035	0.66	0.89
Е	0.045	0.055	1.14	1.40
F	0.122 REF		3.10 REF	
G	0.100 BSC		2.54 BSC	
Н	0.094	0.110	2.39	2.79
J	0.013	0.025	0.33	0.64
K	0.500	0.562	12.70	14.27
S	0.390 REF		9.90 REF	
٧	0.045	0.070	1.14	1.78
W	0.522	0.551	13.25	14.00

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